



Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)			ATTY. DKT. NO. 5119-08601 APPLICANT: Choi et al. FILING DATE: October 27, 2000			SERIAL NO. 09/698,317 GROUP: 2859		
U.S. PATENT DOCUMENTS								
EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
<i>JMP</i>	A1	3,807,027	4/1974	Heisler	29	423		
<i>JMP</i>	A2	3,807,029	4/1974	Troeger	29	436		
<i>JMP</i>	A3	3,811,665	5/1974	Seelig	26	RECEIVED		
<i>JMP</i>	A4	4,062,600	12/1977	Wyse	384	705	6/2002	
<i>JMP</i>	A5	4,098,001	7/1978	Watson	33	644		
<i>JMP</i>	A6	4,155,169	5/1979	Drake et al.	33	GROUP 3600		
<i>JMP</i>	A7	4,202,107	5/1980	Watson	33	644		
<i>JMP</i>	A8	4,267,212	5/1981	Sakawaki	427	240		
<i>JMP</i>	A9	4,337,579	7/1982	De Fazio	33	644		
<i>JMP</i>	A10	4,355,469	10/1982	Nevins et al.	267	150		
<i>JMP</i>	A11	4,414,750	11/1983	De Fazio	267	166		
<i>JMP</i>	A12	4,451,507	5/1984	Beltz et al.	427	240		
<i>JMP</i>	A13	4,610,442	9/1986	Oku et al.	269	73		
<i>JMP</i>	A14	4,694,703	11/1987	Routson	74	5F		
<i>JMP</i>	A15	4,731,155	3/1988	Napoli et al.	266	44		
<i>JMP</i>	A16	4,763,886	8/1988	Takei	269	73		
<i>JMP</i>	A17	4,929,083	5/1990	Brunner	356	400		
<i>JMP</i>	A18	4,959,252	11/1990	Bonnebat et al.	428	64.7		
<i>JMP</i>	A19	5,072,126	12/1991	Progler	250	548		
<i>JMP</i>	A20	5,110,514	5/1992	Soane	264	496		
<i>JMP</i>	A21	5,126,006	6/1992	Cronin et al.	438	702		
<i>JMP</i>	A22	5,204,739	4/1993	Domenicali	348	79		
<i>JMP</i>	A23	5,240,550	8/1993	Boehnke et al.	216	24		
<i>JMP</i>	A24	5,348,616	9/1994	Hartman et al.	216	48		
<i>JMP</i>	A25	5,392,123	2/1995	Marcus et al.	356	625		
<i>JMP</i>	A26	5,425,964	6/1995	Southwell et al.	427	10		
<i>JMP</i>	A27	5,452,090	9/1995	Progler et al.	356	401		

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Thomas M. Rognan

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Feb. 13, 2009

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III. PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
TMB	A28	5,480,047	1/1996	Tanigawa et al.	216	12	
TMB	A29	5,512,131	4/1996	Kumar et al.	438	35	RECEIVED
TMB	A30	5,515,167	5/1996	Ledger et al.	356	595	JUN 20 2002
TMB	A31	5,545,367	10/1996	Bae et al.	264	481	GROUP 3600
TMB	A32	5,566,584	10/1996	Briganti et al.	74	990	
TMB	A33	5,633,505	5/1997	Chung et al.	250	491.1	
TMB	A34	5,724,145	3/1998	Kondo et al.	356	632	
TMB	A35	5,753,014	5/1998	Van Rijn	96	12	
TMB	A36	5,760,500	6/1998	Kondo et al.	310	12	
TMB	A37	5,772,905	6/1998	Chou	216	44	
TMB	A38	5,776,748	7/1998	Singhvi et al.	435	180	
TMB	A39	5,779,799	7/1998	Davis	118	663	
TMB	A40	5,802,914	9/1998	Fassler et al.	74	110	
TMB	A41	5,877,036	3/1999	Kawai	438	16	
TMB	A42	5,877,861	3/1999	Ausschnitt et al.	356	401	
TMB	A43	5,888,650	3/1999	Calhoun et al.	428	354	
TMB	A44	5,900,160	5/1999	Whitesides et al.	216	41	
TMB	A45	5,912,049	6/1999	Shirley	427	240	
TMB	A46	5,942,871	8/1999	Lee	318	611	
TMB	A47	5,948,470	9/1999	Harrison et al.	427	148	
TMB	A48	5,952,127	9/1999	Yamanaka	430	5	
TMB	A49	6,038,280	3/2000	Rossiger et al.	378	50	
TMB	A50	6,039,897	3/2000	Lochhead et al.	264	1,24	
TMB	A51	6,046,056	4/2000	Parce et al.	204	402.05	
TMB	A52	6,051,345	4/2000	Huang	430	5	
TMB	A53	6,074,827	6/2000	Nelson et al.	435	6	
TMB	A54	6,091,485	7/2000	Li et al.	356	73	
	ASS	6,128,085	10/2000	Buermann et al.	356	369	

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Almenor M. Doyle, Jr.

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Form PTO-1449 (modified)		ATTY. DKT. NO. 5119-08601	SERIAL NO. 09/698,317
List of Patents and Publications			
For Applicant's Information Disclosure Statement JUN 21 2002 (Use several sheets if necessary)			
		APPLICANT: Choi et al.	GROUP: 2859
FILING DATE: October 27, 2000			

U.S. PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
JMD	A56	6,143,412	11/2000	Schueller et al.	428	408	
JMN	A57	6,168,845	1/2001	Fontana, Jr. et al.	428	65.5	RECEIVED
JMD	A58	6,180,239	1/2001	Whitesides et al.	428	411.1	JUN 26 2002
JMD	A59	6,204,922	3/2001	Chalmers	356	73	GROUP 3600
JMH	A60	6,334,960	1/2002	Wilson et al.	216	52	

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
JMD	A61	00/54107	9/2000	WO	608F-	7/00	
MHD	A62	01/33232	5/2001	WO	601R	—	
MHD	A63	01/33300	5/2001	WO	H02K	5/24	
JMN	A64	244884	3/1987	EP	82AC	33/34	
JMN	A65	733455	9/1996	EP	82AC	33/34	NO
JMD	A66	2800476	7/1978	DE	603C	5/05	NO
JMD	A67	19648844	11/1999	DE	82AC	59/02	NO
JMD	A68	1-196749	8/1989	JP	611B	7/26	NO

EXAMINER: Thomas M. Dayhong

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OTHER ARTS (Including Author, Title, Date, Pertinent Pages, Etc.)				
	A69	Stewart, D.; "A Platform with Six Degrees of Freedom", Proc. of Inst. Mech. Engrs., 1965, 180, 371-378.		
	A70	Paros, J.M.; Weisbord, L.; "How to Design Flexure Hinges", Machine Design, 1965, 151-156.		
	A71	Raibert, M.H.; Craig, J.J.; "Hybrid Position/Force Control of Manipulators", 1981, 102, 126-133.		
	A72	Hogan, Neville; "Impedance Control: An Approach to Manipulation", Journal of Dynamic Systems, Measurement and Control, 1985, 107, 1-7.		
	A73	Hollis, Ralph; Salcudean, S.E.; Allan, A.P.; "A Six-Degree-of-Freedom Magnetically Levitated Variable Compliance Fine-Motion Wrist: Design, Modeling and Control", IEEE Transactions on Robotics and Automation, 1991, 7, 320-332.		
	A74	Tomita, Y. et al.; "6-Axes Motion Control Method for Parallel-Linkage-Type Fine Motion Stage", Journal of Japan Society of Precision Engineering, 1992, 118-124.		
	A75	Slocum, Alexander; "Precision Machine Design: Macromachine Design Philosophy and its Applicability to the Design of Micromachines", Proc. of IEEE Micro Electro Mech. Systems Workshop, 1992, 37-42.		
	A76	Krug, Herbert; Merl, Norbert; Schmidt, Helmut; "Fine Patterning of Thin Sol-Gel Films", Journal of Non-Crystalline Solids, 1992, 447-450.		
	A77	Arai, T.; Larsonneur, R.; Jaya, Y.M.; "Calibration and Basic Motion of a Micro Hand Module", Proc. of IECON, 1993, 1660-1665.		
	A78	Peng, Zhi-Xin; Adachi, N.; "Compliant Motion Control of Kinematically Redundant Manipulators", IEEE Transactions on Robotics and Automation, 1993, 9, 831-837.		
	A79	Rong, Y.; Zhu, Y.; Luo, Z.; Liu, X.; "Design and Analysis of Flexure-Hinge Mechanism Used in Micro-Positioning Stages", ASME, 1994, 2, 979-985.		
	A80	Hashimoto, M.; Imamura, Y.; "Design and Characteristics of a Parallel Link Compliant Wrist", IEEE International Conference on Robotics and Automation, 1994, 2457-2462.		
	A81	Merlet, J.P.; "Parallel Manipulators: State of the Art and Perspectives", Advanced Robotics, 1994, 8, 589-596.		
	A82	Ananthasuresh, S.; Kikuchi, N.; "Strategies for Systematic Synthesis of Compliant MEMS", ASME, 1994, 2, 677-686.		
	A83	Arai, T.; Tanikawa, T.; Merlet, J.P.; Sendai, T., "Development of a New Parallel Manipulator with Fixed Linear Actuator", Proc. of Japan/USA Symposium on Flexible Automation, 1996, 1, 145-149.		
	A84	Howell, L.L.; Midha, A.; "Loop-Closure Theory of the Analysis and Synthesis of Compliant Mechanisms", Journal of Mechanical Design, 1996, 118, 121-125.		
	A85	Haisma, J. et al.; "Mold-Assisted Nanolithography: A Process for Reliable Pattern Replication", Journal of Vacuum Science and Technology, 1996, 14, 4124-4128.		
	A86	Pernette, Eric; Henein, Simon; Magnani, Ivo; Clavel, Reymond; "Design of Parallel Robots in Microrobotics", Robotica, 1997, 15, 417-420.		

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ATTY. DKT. NO. 5119-08601 JUN 26 2002 APPLICANT: Choi et al. GROUP 3600 FILING DATE: October 27, 2000		
	A87	Rong, L.; Guangming, "Dynamics of Parallel Mechanism with Direct Compliance Control", IEEE, 1997, 1753-1758.
	A88	Mittal, Samir; Menq, Chia-Hsiang; "Precision Motion Control of Magnetic Suspension Actuator Using a Robust Nonlinear Compensation Scheme", IEEE/ASME Transactions on Mechatronics, 1997, 2, 268-280.
	A89	Physik Instruments, Product Catalog for Micropositioning, 1997.
	A90	Williams, Mark et al.; "Six Degree of Freedom Mag-Lev Stage Development", SPIE, 1997, 3051, 856-867.
	A91	Lee, Chang-Woo; Kim, Seung-Woo; "Ultraprecision Stage for Alignment of Wafers in Advanced Microlithography", Precision Engineering, 1997, 21, 113-122.
	A92	Kanetomo, M.; Kashima, H.; Suzuki, T.; "Robot for Use in Ultrahigh Vacuum", Solid State Tech., 1997, 63-72.
	A93	Goldfarb, M.; Speich, J.; "Compliant Micromanipulator Design for Scaled Bilateral Telemanipulation of Small-Scale Environments", ASME, Dynamic Systems and Control Div., 1998, 64, 213-218.
	A94	Koseki, Y. et al.; "Design and Accuracy Evaluation of High-Speed and High Precision Parallel Mechanism", Proc. of IEEE, Intl. Conf. on Robotics & Automation, 1998, 1340-1345.
	A95	Kim, Won-Jong; Trumper, David; "High Precision Magnetic Levitation Stage for Photolithography", Precision Engineering, 1998, 22, 66-77.
	A96	Mansky, P. et al.; "Large-Area Domain Alignment in Block Copolymer Thin Films Using Electric Fields", Macromolecules, 1998, 31, 4399-4401.
	A97	Wang, W.; Loh, R.; Gu, E.; "Passive Compliance Versus Active Compliance in Robot-Based Automated Assembly Systems", Industrial Robot, 1998, 25, 48-57.
	A98	Scheer, H.C. et al.; "Problems of Nanoimprinting Technique for Nanometer Scale Pattern Definition", Journal of Vacuum Science and Technology, 1998, 16, 3917-3921.
	A99	Xia, Y.; Whitesides, George; "Soft Lithography", Annu. Rev. Mater. Sci., 1998, 28, 153-184.
	A100	Tajbakhsh, H. et al.; "Three-Degree-of-Freedom Optic Mount for Extreme Ultraviolet Lithography", ASPE, 1998, 18, 359-362.
	A101	Lee, Dong Sung et al.; "Ultra Precision Positioning System for Servo Motor-Piezo Actuator Using Dual Servo Loop and Digital Filter Implementation", ASPE, 1998, 18, 287-290.
	A102	Wu, Wei et al.; "Large Area High Density Quantized Magnetic Disks Fabricated Using Nanoimprint Lithography", 1998, Journal of Vacuum Science and Technology, 1998, 16, 3825-3829.
	A103	Ohya, Y. et al.; "Development of 3-DOF Finger Module for Micro Manipulation", Proc. of IEEE, Intl. Conf. on Intelligent Robots and Systems, 1999, 894-899.
	A104	Tanikawa, T. et al.; "Development of Small-Sized 3 DOF Finger Module in Micro Hand for Micro Manipulation", Proc. of IEEE, Intl. Conf. on Intelligent Robots and Systems, 1999, 876-881.
	A105	Colburn, M. et al.; "Step and Flash Imprint Lithography: New Approach to High-Resolution Patterning", Proc. of SPIE, 1999, 3676, 379-389.

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		FILING DATE: October 27, 2000	GROUP	3600
DNP	A106	Lucas Aerospace, Free-Flex Pivot Catalog, 1999		
TMB	A107	Goldfarb, M.; Speich, J.E.; "A Well-Behaved Revolute Flexure Joint for Compliant Mechanism Design", Journal of Mech. Design, 1999, 121, 424-429.		
TMB	A108	Geodetic Technology, G1000-PS Power Series Specifications, 1999, from www.hexapods.com		
TMB	A109	Hexel Corporation, Tornado 2000 System Specifications, 1999, from www.hexel.com		
TMB	A110	Physik Instruments, PI Online-Catalog, 1999, from www.physikinstruments.com		
TMB	A111	Chou, Stephen; Zhuang, Lei; "Lithographically-induced Self Assembly of Periodic Micropillar Arrays", Journal of Vacuum Science and Technology, 1999, 17, 3197-3202.		
TMB	A112	Ruchhoeft, P. et al.; "Patterning Curved Surfaces: Template Generation by Ion Beam Proximity Lithography and Relief Transfer by Step and Flash Imprint Lithography", Journal of Vacuum Science and Technology, 1999, 17, 2965-2982.		
TMB	A113	Vanderbilt University Office of Transfer Technology; VU 9730 Specifications for Improved Flexure Device; 2001, from www.vanderbilt.edu		
TMB	A114	Stix, Gary, "Getting More from Moore's", Scientific American, 2001, from www.scientificamerican.com		
TMB	A115	Trilogy Systems, Linear Motors 310 Specification, 2001, from www.trilogysystems.com		
TMB	A116	Choi, B.J. et al.; "Design of Orientation Stages for Step and Flash Imprint Lithography", Precision Engineering, 2001, 25, 192-199.		
TMB	A117	PCT International Search Report for PCT/US 00/30041, dated 10/15/2001		
TMB	A118	PCT International Search Report for PCT/US 01/26049, dated 2/19/2002		

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